GENE-A55E A1.1

Temperature/Humidity Test Report

Report NO:

Pass .
□ Fail Note: There is/are defect(s) not list in the report, please check it in the DTS Website.

Issue date	QE Manager	Test Engineer
2016-09-26	Dinken Chuang	Yungtang Lin

Test item list

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Testing Result

Num	Test item list	Result	Remark
1	Temp./humidity power on/offtest	Pass	
2	Temperaturevariationoperation test	Pass	
3	Cold start and hot start test	Pass	

Configuration of EUT

Test Product: GENE-A55E A1.1

Sample Configuration & Quantity Under Test:

- 1. CPU:AMD T40R/1GHz
- 2. BIOS Ver.R1.5 GA5EAM15(07/27/2016)
- 3. Chipset: AMD A55E
- 4. Memory: Transcend 2GB * 1/ DDR3L 1600 / SEC K4B2G0846Q
- 5. USB Flash: Transcend 8GB (For DOS Mode Power On/Off Test)
- 6. 3.5" SATA HDD: HITACHI H3D3201672S / 320GB
- 7. Test Software: Windows 7 / Run PassMark Burn In Test 8.1 Pro
- 8. AT Power Supply: EMACS HG2-6400P / 400W (AT to ATX Mode)
- 9. Heat Sink:





Temp./humidity power on/offtest

Test Date:09-19 ~ 20-2016

Test Site: AAEON Taichung Internal Lab

Test Standard: Refer to IEC 68-2-30 Testing procedures

Test Db: Damp Heat Test Refer to IEC 68-2-1 Testing procedures

Test Ad: Cold Test

Test Equipment:

Programmable Temperature & Humidity Chamber: (K.SON. INS. TECH. CORP.)

Model: MHU-150LB

Date of Calibration: 01/26/16 Due date of Calibration: 01/25/17

Serial Number: 961138

Temperature & Humidity Power On/Off Test:

1. Test High Temp./Humidity: 60°C @90%RH

Test Low Temperature: 0°C
 Test Time: 24Hours / Cycle

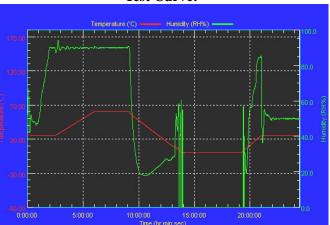
4. Test Cycle: 1 Cycles

5. Test Software: DOS Mode / Run Boot Up Record Program ver 1.41

Testing Specification:

Step	Temperature (°C	Humidity (%RH)	Duration (HH:MM)
1	25	50	00:30
2	25	50	00:30
3	25	90	01:00
4	25	90	00:30
5	60	90	03:30
6	60	90	03:00
7	0	0	04:50
8	0	0	05:23
9	25	50	01:47
10	25	50	03:00

Test Curve:



Test Result:

Test Method	Actual	Successful	Failure rate	Test Result
Power On/Off	1832/times	1832/times	0 %	

Note: 1. Failure rate need to under 0%.

2. Power on/off fixture setting: on - 35 sec / off - 5 sec

Temperature variation operation test

Test Date:09-21 ~ 22-2016

Test Site: AAEON Taichung Internal Lab

Test Standard: Refer to IEC 68-2-14 Testing procedures

Test N: Change of temperature Test

Test Equipment:

Programmable Temperature & Humidity Chamber: (K.SON. INS. TECH. CORP.)

Model: MHU-150LB

Date of Calibration: 01/26/16 Due date of Calibration: 01/25/17

Serial Number: 961138

Temperature & Humidity Cycle Test:

1. Test Low Temperature: 0° C (1~3 cycles)

2. Test High Temperature: 60° C (1~3 cycles)

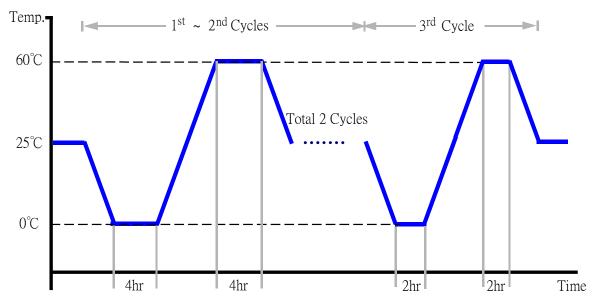
3. Test dwell time: 4Hrs(1~2 cycles)

2Hrs (3rdcycle)

4. Temperature slope: 2°C/min

5. Test cycle: 3 cycles

6. Test Environment Curve:



Test Result:

No issueswere found during the temperature variation operation test.

Cold start and hot start test

Test Date:09-23 ~ 23-2016

Test Site: AAEON Taichung Internal Lab

Test Standard: Refer to IEC 68-2-14 Testing procedures

Test N: Change of temperature Test

Test Equipment:

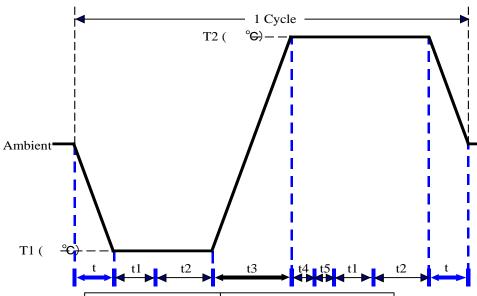
Programmable Temperature & Humidity Chamber: (K.SON. INS. TECH. CORP.)

Model: MHU-150LB

Date of Calibration: 01/26/16 Due date of Calibration: 01/25/15

Serial Number: 961138

Test Condition:



Parameters	Description
T1	0°℃
T2	60°C
t1	1 hrs
t2	2 hrs
t4, t5	30 min
t, t3	2°C/min
n (Cycle)	1

t,t3 = temprature slope

t, t1: Power Off

t2: Power on/off test 10 times (on 2 min / off 5min)

t3,t4: Run PassMark Burn In Test

t5: Windows 8 Software restart test 2 times

Test Software: Windows 8

Test Result:

- a. No issues were found during the cold start test.
- b. No issues were found during the hot start test.